

INTERNATIONAL STANDARD

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BASIC EMC PUBLICATION
PUBLICATION FONDAMENTALE EN CEM

**Electromagnetic compatibility (EMC) –
Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic
field immunity test**

**Compatibilité électromagnétique (CEM) –
Partie 4-10: Techniques d'essai et de mesure – Essai d'immunité du champ
magnétique oscillatoire amorti**



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTROMAGNETIC COMPATIBILITY (EMC) –**Part 4-10: Testing and measurement techniques –
Damped oscillatory magnetic field immunity test**

FOREWORD

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International Standard IEC 61000-4-10 has been prepared by subcommittee 77B: High frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

It forms Part 4-10 of the IEC 61000 series. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This second edition cancels and replaces the first edition published in 1993 and Amendment 1:2000. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) new Annex A on induction coil field distribution;
- b) new Annex D on measurement uncertainty;

- c) new Annex E for numerical simulations;
- d) calibration using current measurement has been addressed in this edition.

The text of this standard is based on the following documents:

CDV	Report on voting
77B/730/CDV	77B/746A/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61000 series, published under the general title *Electromagnetic compatibility (EMC)*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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INTRODUCTION

IEC 61000 is published in separate parts according to the following structure:

Part 1: General

General considerations (introduction, fundamental principles)

Definitions, terminology

Part 2: Environment

Description of the environment

Classification of the environment

Compatibility levels

Part 3: Limits

Emission limits

Immunity limits (insofar as they do not fall under the responsibility of the product committees)

Part 4: Testing and measurement techniques

Measurement techniques

Testing techniques

Part 5: Installation and mitigation guidelines

Installation guidelines

Mitigation methods and devices

Part 6: Generic standards

Part 9: Miscellaneous

Each part is further subdivided into several parts, published either as international standards or as technical specifications or technical reports, some of which have already been published as sections. Others will be published with the part number followed by a dash and a second number identifying the subdivision (example: IEC 61000-6-1).

This part is an international standard which gives immunity requirements and test procedures related to "damped oscillatory magnetic field".

ELECTROMAGNETIC COMPATIBILITY (EMC) –

Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic field immunity test

1 Scope and object

This part of IEC 61000 specifies the immunity requirements, test methods, and range of recommended test levels for equipment subjected to damped oscillatory magnetic disturbances related to medium voltage and high voltage sub-stations.

The test defined in this standard is applied to equipment which is intended to be installed in locations where the phenomenon as specified in Clause 4 will be encountered.

This standard does not specify disturbances due to capacitive or inductive coupling in cables or other parts of the field installation. IEC 61000-4-18, which deals with conducted disturbances, covers these aspects.

The object of this standard is to establish a common and reproducible basis for evaluating the performance of electrical and electronic equipment for medium voltage and high voltage sub-stations when subjected to damped oscillatory magnetic fields.

The test is mainly applicable to electronic equipment to be installed in H.V. sub-stations. Power plants, switchgear installations, smart grid systems may also be applicable to this standard and may be considered by product committees.

NOTE As described in IEC Guide 107, this is a basic EMC publication for use by product committees of the IEC. As also stated in Guide 107, the IEC product committees are responsible for determining whether this immunity test standard is applied or not, and if applied, they are responsible for determining the appropriate test levels and performance criteria. TC 77 and its sub-committees are prepared to co-operate with product committees in the evaluation of the value of particular immunity test levels for their products.

This standard defines:

- a range of test levels;
- test equipment;
- test setups;
- test procedures.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050 (all parts), *International Electrotechnical Vocabulary (IEV)* (available at www.electropedia.org)